


# Memory modul - FL IF MEM 2TX-D - 2832483

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Memory module, 2 port twisted pair module for saving the switch configuration



## Key commercial data

Packing unit	1 pc
GTIN	 4 017918 974497
Weight per Piece (excluding packing)	91.8 g
Custom tariff number	85176200
Country of origin	Germany

## Technical data

### Dimensions

Width	31 mm
Height	78 mm
Depth	72.5 mm

### Ambient conditions

Degree of protection	IP20
Ambient temperature (operation)	0 °C ... 55 °C (non-condensing)
Ambient temperature (storage/transport)	-20 °C ... 70 °C
Permissible humidity (operation)	10 % ... 95 % (non-condensing)
Permissible humidity (storage/transport)	10 % ... 95 % (non-condensing)
Noise immunity	EN 61000-6-2:2005

### Interfaces

Interface 1	Ethernet 10/100Base T
No. of ports	2
Connection method	RJ45 socket
Transmission physics	Copper
Transmission speed	10/100 MBit/s

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## Technical data

### Interfaces

Transmission length	100 m
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### Function

Basic functions	Configuration memory (plug-in)
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### Supply voltage

Supply voltage	(via head station)
Typical current consumption	10 mA

### General

Mounting type	In the host system
Type AX	Fine granularity
Weight	70 g
Housing material	PA
Noise emission	EN 61000-6-3/-4

### Conformity with EMC directives

Developed in acc. with standard	IEC 61000-6.2
Test standard	IEC 61000-4-2 (ESD)
Test result	Criterion B
Test standard	IEC 61000-4-3 (immunity to radiated interference)
Test result	Criterion A
Test standard	IEC 61000-4-4 (burst)
Test result	Criterion A
Test standard	IEC 61000-4-5 (surge)
Test result	Criterion A
Test standard	IEC 61000-4-6 (immunity to conducted interference)
Test result	Criterion A
Test standard	IEC 61000-4-8 (immunity to magnetic fields)
Test result	Criterion A
Test standard	EN 55022 (emitted interference)
Test result	Criterion A

## Classifications

### eCl@ss

eCl@ss 4.0	27250501
eCl@ss 4.1	27250501
eCl@ss 5.0	27250501
eCl@ss 5.1	27250501
eCl@ss 6.0	19170106
eCl@ss 7.0	19170106
eCl@ss 8.0	19170106

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## Classifications

### ETIM

ETIM 2.0	EC000734
ETIM 3.0	EC000734
ETIM 4.0	EC001467
ETIM 5.0	EC001467

### UNSPSC

UNSPSC 6.01	43172015
UNSPSC 7.0901	43201404
UNSPSC 11	43172015
UNSPSC 12.01	43201410
UNSPSC 13.2	43201410

## Approvals

### Approvals

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#### Approvals

UL Recognized / cUL Recognized / LR / GL / BV / DNV / ABS / GL-SW / cULus Recognized / GL

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#### Ex Approvals

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#### Approvals submitted

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## Approval details

UL Recognized
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cUL Recognized
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LR
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GL
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BV
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### Approvals

DNV

ABS

GL-SW

cULus Recognized 

GL